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Page(s): 271 -277

[\[Abstract\]](#) [\[PDF Full-Text \(360 KB\)\]](#) **IEEE CNF****2 Scheduling data redistribution in distributed databases***Rivera-Vega, P.I.; Varadarajan, R.; Navathe, S.B.;*

Data Engineering, 1990. Proceedings. Sixth International Conference on , 5-9 April 1990

Page(s): 166 -173

[\[Abstract\]](#) [\[PDF Full-Text \(624 KB\)\]](#) **IEEE CNF****3 Query processing for a knowledge-base using DOT algebra***Tsukamoto, M.; Fujio, M.; Miyamoto, M.; Nishio, S.;*

Interoperability in Multidatabase Systems, 1991. IMS '91. Proceedings., First International Workshop on , 7-9 April 1991

Page(s): 46 -53

[\[Abstract\]](#) [\[PDF Full-Text \(548 KB\)\]](#) **IEEE CNF****4 Improved network inversion technique for query learning application automated cytology screening***Davis, D.T.; Hwang, J.-N.; Lee, J.S.-J.;*

Computer-Based Medical Systems, 1991. Proceedings of the Fourth Annual IEEE Conference on , 1991

Symposium , 12-14 May 1991

Page(s): 313 -320

[\[Abstract\]](#) [\[PDF Full-Text \(388 KB\)\]](#) **IEEE CNF**

---

**5 Optimizing multi-joint queries in parallel relational databases**

*Srivastava, J.; Elssesser, G.;*

Parallel and Distributed Information Systems, 1993., Proceedings of the Second International Conference on , 20-22 Jan. 1993

Page(s): 84 -92

[\[Abstract\]](#) [\[PDF Full-Text \(792 KB\)\]](#) **IEEE CNF**

---

**6 Managing different aspects of imperfect data in databases: a unified approach**

*Kurutach, W.;*

Systems, Man and Cybernetics, 1995. 'Intelligent Systems for the 21st Century International Conference on , Volume: 3 , 22-25 Oct. 1995

Page(s): 2812 -2817 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(516 KB\)\]](#) **IEEE CNF**

---

**7 A comparison of feature selection algorithms in the context of rough classifiers**

*Choubey, S.K.; Deogun, J.S.; Raghavan, V.V.; Sever, H.;*

Fuzzy Systems, 1996., Proceedings of the Fifth IEEE International Conference on , Volume: 2 , 8-11 Sept. 1996

Page(s): 1122 -1128 vol.2

[\[Abstract\]](#) [\[PDF Full-Text \(688 KB\)\]](#) **IEEE CNF**

---

**8 On the structure of queries in constraint query languages**

*Benedikt, M.; Libkin, L.;*

Logic in Computer Science, 1996. LICS '96. Proceedings., Eleventh Annual IEEE Symposium on , 27-30 July 1996

Page(s): 25 -34

[\[Abstract\]](#) [\[PDF Full-Text \(924 KB\)\]](#) **IEEE CNF**

---

**9 The impact of seeking in partial match retrieval**

*Vakali, A.; Manolopoulos, Y.;*

Database and Expert Systems Applications, 1996. Proceedings., Seventh International Workshop on , 9-10 Sept. 1996

Page(s): 432 -437

[\[Abstract\]](#) [\[PDF Full-Text \(476 KB\)\]](#) **IEEE CNF**

---

**10 Focused color intersection with efficient searching for object detection image retrieval**

*Vinod, V.V.; Murase, H.; Hashizume, C.;*

Multimedia Computing and Systems, 1996., Proceedings of the Third IEEE International Conference on , 17-23 June 1996

Page(s): 229 -233

[\[Abstract\]](#) [\[PDF Full-Text \(416 KB\)\]](#) **IEEE CNF**

---

**11 Exploration of very large databases by self-organizing maps**

*Kohonen, T.;*

Neural Networks, 1997., International Conference on , Volume: 1 , 9-12 June 1997

Page(s): PL1 -PL6 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(636 KB\)\]](#) **IEEE CNF**

---

**12 NeTra: a toolbox for navigating large image databases**

*Ma, W.Y.; Manjunath, B.S.;*

Image Processing, 1997. Proceedings., International Conference on , Volume: 1 , 26-29 Oct. 1997

Page(s): 568 -571 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(620 KB\)\]](#) **IEEE CNF**

---

**13 Query processing issues in image (multimedia) databases**

*Nepal, S.; Ramakrishna, M.V.;*

Data Engineering, 1999. Proceedings., 15th International Conference on , 23-27 June 1999

Page(s): 22 -29

[\[Abstract\]](#) [\[PDF Full-Text \(148 KB\)\]](#) **IEEE CNF**

---

**14 An index structure for spatial joins in linear constraint databases**

*Hongjun Zhu; Jianwen Su; Ibarra, O.H.;*

Data Engineering, 1999. Proceedings., 15th International Conference on , 23-27 June 1999

Page(s): 636 -643

[\[Abstract\]](#) [\[PDF Full-Text \(256 KB\)\]](#) **IEEE CNF**

---

**15 Fast approximate answers to aggregate queries on a data cube***Poosala, V.; Ganti, V.;*

Scientific and Statistical Database Management, 1999. Eleventh International Conference on , 28-30 July 1999

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Real-Time Computing Systems and Applications, 1999. RTCSA '99. Sixth International Conference on , 13-15 Dec. 1999

Page(s): 348 -355

[\[Abstract\]](#) [\[PDF Full-Text \(648 KB\)\]](#) **IEEE CNF****17 Optimizing join queries in distributed databases***Pramanik, S.; Vineyard, D.;*

Software Engineering, IEEE Transactions on , Volume: 14 Issue: 9 , Sept. 1988

Page(s): 1319 -1326

[\[Abstract\]](#) [\[PDF Full-Text \(708 KB\)\]](#) **IEEE JNL****18 One-step pointer forwarding strategy for location tracking in distributed HLR environment***Kuen-Liang Sue; Chien-Chao Tseng;*

Selected Areas in Communications, IEEE Journal on , Volume: 15 Issue: 8 , Oct

Page(s): 1455 -1466

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